424

1.7

(AW) 77

0.9

0.8

0

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Fig. 2. Current-voltage characteristics of Al-I-In samples at different pressures. $T=(1.17\pm0.02)$ °K; normalized units are along the *I*-axis

 $2\Delta(P) = 3.69 kT_c$

10

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where the error does not include the inaccuracy in pressure measurement. Such $T_{\rm e}$ change of In films with pressure excellently coincides with Berman. Brandt, and Ginzburg's measurements [10] on massive indium.

Fig. 2 shows voltage-current characteristics for two Al-I-In samples plotted at different pressures. The energy gap was defined from the maxima of the (dI/dU)-U characteristics (Fig. 3).

Fig. 4 shows the result of high pressure influence on the energy gap of indium. For comparison the $2 \Delta(p) = 3.69 kT_c$ line is drawn which in fact corresponds to the critical temperature change. The gap values obtained by extrapolating $2\Delta(T)$ to T = 0 °K are also included in Table 1. From experiments it is found

$$rac{{
m d}\,2\,{\it \Delta}}{{
m d}p}=-\,(1.43\,\pm\,0.13)\! imes\!10^{-5}rac{{
m meV}}{{
m atm}}\,.$$

The energy gap of In at zero pressure, $2 \Delta(0.0) = (3.69 \pm 0.04) kT_c$, is in good agreement with data obtained from precision measurements of critical field

where

curves [11], where the coefficient defining a deviation from the parabola was found to be



$$\gamma = \frac{2}{3} \pi^2 \, k^2 \, N \,. \tag{4}$$

